## Notice of References Cited

Application/Control No.

09/486,480

Examiner

S. Devi, Ph.D.

Applicant(s)/Patent Under Reexam

Spudich et al.

Art Unit

1645

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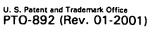
	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>
N	JP 356152741A	11/26/81	Japan	Sugimori et al.	
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<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>2</sup> Classifications may be U.S. or foreign.



<sup>&</sup>lt;sup>1</sup> Dates in MM-YYYY format are publication dates.